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Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

2 0 0 0 0 0	
Product Status	Obsolete
Core Processor	RL78
Core Size	16-Bit
Speed	24MHz
Connectivity	CSI, I ² C, LINbus, UART/USART
Peripherals	DMA, LCD, LVD, POR, PWM, WDT
Number of I/O	37
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	1K x 8
Voltage - Supply (Vcc/Vdd)	1.6V ~ 5.5V
Data Converters	A/D 10x8/10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	52-LQFP
Supplier Device Package	52-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/renesas-electronics-america/r5f10rjaafa-v0

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Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

1.3.5 64-pin products

• 64-pin plastic WQFN (8 × 8)

<R>



Cautions 1. Make EVss pin the same potential as Vss pin.

- 2. Make VDD pin the same potential as EVDD pin.
- 3. Connect the REGC pin to Vss via a capacitor (0.47 to 1 μ F).

Remarks 1. For pin identification, see 1.4 Pin Identification.

- When using the microcontroller for an application where the noise generated inside the microcontroller must be reduced, it is recommended to supply separate powers to the V_{DD} and EV_{DD} pins and connect the V_{SS} and EV_{SS} pins to separate ground lines.
- **3.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR).

RENESAS

1.5 Block Diagram

1.5.1 32-pin products



Remark Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register (PIOR)



Items	Symbol		Conditions		MIN.	TYP.	MAX.	Unit
Output current, Iow ^{Note 1}	urrent, IoL1	P50 to P54	Per pin for P10 to P17, P30 to P32, P40 to P43, P50 to P54, P70 to P74, P120, P125 to P127, P130, P140 to P147				20.0 Note 2	mA
		Per pin for	P60, P61			15.0 Note 2	mA	
		Total of P1	0 to P14, P40 to P43,	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$			70.0	mA
			0, P140 to P147	$2.7~V \leq EV_{\text{DD}} < 4.0~V$			15.0	mA
		(when dut	y = 70% ^{Note 3})	$1.8 \text{ V} \le \text{EV}_{\text{DD}} < 2.7 \text{ V}$			9.0	mA
				$1.6~V \leq EV_{\text{DD}} < 1.8~V$			4.5	mA
		Total of P1	P15 to P17, P30 to P32,	$4.0~V \leq EV_{\text{DD}} \leq 5.5~V$			80.0	mA
			4, P60, P61, P70 to P74,	$2.7~V \leq EV_{\text{DD}} < 4.0~V$			35.0	mA
		P125 to P1 (When duty	127 y = 70% ^{Note 3})	$1.8 \text{ V} \le \text{EV}_{\text{DD}} < 2.7 \text{ V}$			20.0	mA
		(,,	$1.6~V \leq EV_{\text{DD}} < 1.8~V$			10.0	mA
		Total of all (When dut	pins y = 70% ^{Note 3})				150.0	mA
	IOL2	P20, P21 Per pin					0.4	mA
			Total of all pins	$1.6~V \le V_{\text{DD}} \le 5.5~V$			0.8	mA

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{\text{DD}} = \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{ Vss} = \text{EV}_{\text{SS}} = 0 \text{ V})$



- **Notes 1**. Value of current at which the device operation is guaranteed even if the current flows from the V_{DD} and EV_{DD} pins to an output pin.
 - 2. Do not exceed the total current value.
 - **3.** Specification under conditions where the duty factor \leq 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins = $(I_{OH} \times 0.7)/(n \times 0.01)$
- <Example> Where n = 80% and IoL = 70.0 mA

Total output current of pins = $(70.0 \times 0.7)/(80 \times 0.01) \approx 61.25$ mA

However, the current that is allowed to flow into one pin does not vary depending on the duty factor. A current higher than the absolute maximum rating must not flow into one pin.

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



	, ,							(0/0
Items Symbol		Conditio	MIN.	TYP.	MAX.	Unit		
nput leakage current, high	ILIH1	P10 to P17, P30 to P32, P40 to P43, P50 to P54, P60, P61, P70 to P74, P120, P125 to P127, P140 to P147	VI = EV _{DD}				1	μA
	ILIH2	P20, P21, P137, RESET	VI = VDD				1	μA
	Ілнз	P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS)	VI = VDD	In input port or external clock input			1	μA
				In resonator connection			10	μA
Input leakage current, low	ILIL1	P10 to P17, P30 to P32, P40 to P43, P50 to P54, P60, P61, P70 to P74, P120, P125 to P127, P140 to P147	VI = EVss				-1	μA
	ILIL2	P20, P21, P137, RESET	VI = VSS				-1	μA
	Ilili3	P121 to P124 (X1, X2, XT1, XT2, EXCLK, EXCLKS)	VI = VSS	In input port or external clock input			-1	μA
				In resonator connection			-10	μA
On-chip pll-up	Ruı	VI = EVss	SEGxx po	rt				
resistance			2.4 V ≤ I	$EV_{DD} = V_{DD} \le 5.5 V$	10	20	100	kΩ
				$EV_{DD} = V_{DD} < 2.4 V$	10	30	100	kΩ
	Ru2			r than above ⁻ P60, P61, and	10	20	100	kΩ

$(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.6 \text{ V} \le \text{EV}_{DD} = \text{V}_{DD} \le 5.5 \text{ V}, \text{V}_{SS} = \text{EV}_{SS} = 0 \text{ V})$

(5/5)

Remark Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



2.3.2 Supply current characteristics

(TA = -40 to $+85^{\circ}$ C, 1.6 V \leq EV_{DD} = V_{DD} \leq 5.5 V, V_{SS} = EV_{SS} = 0 V)

(1/3)

Parameter	Symbol			Conditions		-	MIN.	TYP.	MAX.	Unit								
Supply	IDD1 Operating		HS (high-	f _{IH} = 24 MHz ^{Note 3}	Basic	V _{DD} = 5.0 V		1.5		mA								
current		mode	speed main)		operation	V _{DD} = 3.0 V		1.5		mA								
Note 1			mode ^{Note 5}		Normal	V _{DD} = 5.0 V		3.3	5.0	mA								
					operation	V _{DD} = 3.0 V		3.3	5.0	mA								
				f⊪ = 16 MHz ^{Note 3}	Normal	V _{DD} = 5.0 V		2.5	3.7	mA								
					operation	V _{DD} = 3.0 V		2.5	3.7	mA								
			LS (low-speed	file = 8 MHz ^{Note 3}	Normal	V _{DD} = 3.0 V		1.2	1.8	mA								
		main) mode ^{Note}		operation	V _{DD} = 2.0 V		1.2	1.8	mA									
			LV (low-	f _{IH} = 4 MHz ^{Note 3}	Normal	V _{DD} = 3.0 V		1.2	1.7	mA								
			voltage main) mode ^{Note 5}		operation	V _{DD} = 2.0 V		1.2	1.7	mA								
			HS (high-	f _{MX} = 20 MHz ^{Note 2} ,	Normal	Square wave input		2.8	4.4	mA								
			V _{DD} = 5.0 V	operation	Resonator connection		3.0	4.6	mA									
			f _{MX} = 20 MHz ^{Note 2} ,	Normal	Square wave input		2.8	4.4	mA									
			V _{DD} = 3.0 V	operation	Resonator connection		3.0	4.6	mA									
				f _{MX} = 10 MHz ^{Note 2} ,	Normal	Square wave input		1.8	2.6	mA								
				V _{DD} = 5.0 V	operation	Resonator connection		1.8	2.6	mA								
				$f_{MX} = 10 \text{ MHz}^{\text{Note 2}},$	Normal	Square wave input		1.8	2.6	mA								
		LS (low-speed	V _{DD} = 3.0 V	operation	Resonator connection		1.8	2.6	mA									
			f _{MX} = 8 MHz ^{Note 2} ,	Normal	Square wave input		1.1	1.7	mA									
			main) mode [№] ₅	main) mode ^{Note} ₅	V _{DD} = 3.0 V	operation	Resonator connection		1.1	1.7	mA							
			Subsystem clock operation	f _{MX} = 8 MHz ^{Note 2} ,	Normal	Square wave input		1.1	1.7	mA								
				V _{DD} = 2.0 V	operation	Resonator connection		1.1	1.7	mA								
				f _{SUB} = 32.768 kHz ^{Note}	Normal	Square wave input		3.5	4.9	μA								
				⁴ T _A = −40°C	operation	Resonator connection		3.6	5.0	μA								
				f _{SUB} = 32.768 kHz ^{Note}	Normal	Square wave input		3.6	4.9	μA								
				⁴ T _A = +25°C	operation	Resonator connection		3.7	5.0	μA								
				fsuв = 32.768 kHz ^{Note}	Normal	Square wave input		3.7	5.5	μA								
				₄ T _A = +50°C	operation	Resonator connection		3.8	5.6	μA								
				f _{SUB} = 32.768 kHz ^{Note}	Normal	Square wave input		3.8	6.3	μA								
												₄ T _A = +70°C	operation	Resonator connection		3.9	6.4	μA
				fsuв = 32.768 kHz ^{Note}	Normal	Square wave input		4.1	7.7	μA								
				4	operation	Resonator connection		4.2	7.8	μA								
				T _A = +85°C														

(Notes and Remarks are listed on the next page.)



Minimum Instruction Execution Time during Main System Clock Operation





----- When the high-speed on-chip oscillator clock is selected

--- During self programming

---- When high-speed system clock is selected





TCY VS VDD (LV (low-voltage main) mode)

AC Timing Test Points



External System Clock Timing



(6) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (master mode, SCKp... internal clock output) (3/3) $(T_A = -40 \text{ to } +85^{\circ}\text{C}, 1.8 \text{ V} \le \text{EV}_{\text{DD}} = \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{ Vss} = \text{EV}_{\text{Ss}} = 0 \text{ V})$

Parameter	Symbol			high- I main) ode	speed	(low- main) ode	voltage	(low- e main) ode	Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SIp hold time (from SCKp↓) ^{Note 2}	tksi1	$\begin{array}{l} 4.0 \; V \leq EV_{\text{DD}} \leq 5.5 \; \text{V}, 2.7 \; V \leq V_{\text{b}} \leq 4.0 \; \text{V}, \\ C_{\text{b}} = 30 \; \text{pF}, \; R_{\text{b}} = 1.4 \; \text{k}\Omega \end{array}$	19		19		19		ns
		$\begin{array}{l} 2.7 \ V \leq EV_{DD} < 4.0 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$	19		19		19		ns
		$\begin{array}{l} 2.4 \ V \leq EV_{\text{DD}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$	19		19		19		ns
		$\begin{array}{l} 1.8 \ V \leq EV_{DD} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note 3}}, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$			19		19		ns
Delay time from SCKp↑ to SOp output ^{Note 2}	tkso1	$\begin{array}{l} 4.0 \; V \leq EV_{\text{DD}} \leq 5.5 \; \text{V}, 2.7 \; V \leq V_{\text{b}} \leq 4.0 \; \text{V}, \\ C_{\text{b}} = 30 \; \text{pF}, \; R_{\text{b}} = 1.4 \; \text{k}\Omega \end{array}$		25		25		25	ns
		$\begin{array}{l} 2.7 \ V \leq EV_{\text{DD}} < 4.0 \ V, \ 2.3 \ V \leq V_b \leq 2.7 \ V, \\ C_b = 30 \ pF, \ R_b = 2.7 \ k\Omega \end{array}$		25		25		25	ns
		$\begin{array}{l} 2.4 \ V \leq EV_{\text{DD}} < 3.3 \ V, \ 1.6 \ V \leq V_b \leq 2.0 \ V, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$		25		25		25	ns
		$\begin{array}{l} 1.8 \ V \leq EV_{DD} < 3.3 \ V, \\ 1.6 \ V \leq V_b \leq 2.0 \ V^{\text{Note } 3}, \\ C_b = 30 \ pF, \ R_b = 5.5 \ k\Omega \end{array}$				25		25	ns

- **Notes** 1. When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.
 - 2. When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.
 - **3.** Use it with $EV_{DD} \ge V_b$.
- Caution Select the TTL input buffer for the SIp pin and the N-ch open drain output (V_{DD} tolerance (32-pin to 52pin products)/EV_{DD} tolerance (64-pin products)) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V_{IH} and V_{IL}, see the DC characteristics with TTL input buffer selected.





CSI mode serial transfer timing (master mode) (during communication at different potential) (When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)





Remark p: CSI number (p = 00, 01), m: Unit number (m = 0), n: Channel number (n = 0, 1), g: PIM and POM number (g = 1)

2.6.4 LVD circuit characteristics

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection	Supply voltage level	VLVD0	Power supply rise time	3.98	4.06	4.14	I.14 V I.06 V I.07 V I.08 V I.08 V I.09 V I.02 V I.03 V I.04 V I.05 V I.07 V
voltage			Power supply fall time	3.90	3.98		V
		VLVD1	Power supply rise time	3.68	3.75	3.82	V
	tection Supply voltage level		Power supply fall time	3.60	3.67	3.74	V
		VLVD2	Power supply rise time	3.07	3.13	3.19	V
			Power supply fall time	3.00	3.06	3.12	V
		VLVD3	Power supply rise time	2.96	3.02	3.08	V
			Power supply fall time	2.90	2.96	3.02	V
		VLVD4	Power supply rise time	2.86	2.92	2.97	V
			Power supply fall time	2.80	2.86	2.91	V
		VLVD5	Power supply rise time	2.76	2.81	2.87	V
			Power supply fall time	2.70	2.75	2.81	V
		VLVD6	Power supply rise time	2.66	2.71	2.76	V
			Power supply fall time	2.60	2.65	2.70	V
		VLVD7	Power supply rise time	2.56	2.61	2.66	V
			Power supply fall time	2.50	2.55	2.60	V
		VLVD8	Power supply rise time	2.45	2.50	2.55	V
			Power supply fall time	2.40	2.45	2.50	V
		VLVD9	Power supply rise time	2.05	2.09	2.13	V
			Power supply fall time	2.00	2.04	2.08	V
		VLVD10	Power supply rise time	1.94	1.98	2.02	V
			Power supply fall time	1.90	1.94	1.98	V
		VLVD11	Power supply rise time	1.84	1.88	1.91	V
			Power supply fall time	1.80	1.84	1.87	V
		VLVD12	Power supply rise time	1.74	1.77	1.81	V
			Power supply fall time	1.70	1.73	1.77	V
		VLVD13	Power supply rise time	1.64	1.67	1.70	V
			Power supply fall time	1.60	1.63	1.66	V
Minimum pı	ulse width	tLw		300			μs
Detection d	elay time	t LD				300	μs



LVD Detection Voltage of Interrupt & Reset Mode

(TA = -40 to +85°C, VPDR \leq EVDD = VDD \leq 5.5 V, Vss = EVss = 0 V)

Parameter	Symbol		Conc	litions	MIN.	TYP.	MAX.	Unit
Interrupt and reset	VLVDA0	VPOC2,	VPOC1, VPOC0 = 0, 0, 0	, falling reset voltage	1.60	1.63	1.66	V
mode	VLVDA1		LVIS1, LVIS0 = 1, 0	Rising release reset voltage	1.74	1.77	1.81	V
				Falling interrupt voltage	1.70	1.73	1.77	V
	VLVDA2		LVIS1, LVIS0 = 0, 1	Rising release reset voltage	1.84	1.88	1.91	V
				Falling interrupt voltage	1.80	1.84	1.87	V
	VLVDA3		LVIS1, LVIS0 = 0, 0	Rising release reset voltage	2.86	2.92	2.97	V
				Falling interrupt voltage	2.80	2.86	2.91	V
	VLVDB1	VPOC2,	VPOC1, VPOC0 = 0, 0, 1	, falling reset voltage	1.80	1.84	1.87	V
	VLVDB2		LVIS1, LVIS0 = 1, 0	Rising release reset voltage	1.94	1.98	2.02	V
			Falling interrupt voltage	1.90	1.94	1.98	V	
	VLVDB3	DB3	LVIS1, LVIS0 = 0, 1	Rising release reset voltage	2.05	2.09	2.13	V
				Falling interrupt voltage	2.00	2.04	2.08	V
	VLVDB4	Vlvdb4	LVIS1, LVIS0 = 0, 0	Rising release reset voltage	3.07	3.13	3.19	V
				Falling interrupt voltage	3.00	3.06	3.12	V
	VLVDC0	VPOC2,	VPOC1, VPOC0 = 0, 1, 0	, falling reset voltage	2.40	2.45	2.50	V
	VLVDC1		LVIS1, LVIS0 = 1, 0	Rising release reset voltage	2.56	2.61	2.66	V
				Falling interrupt voltage	2.50	2.55	2.60	V
	VLVDC2		LVIS1, LVIS0 = 0, 1	Rising release reset voltage	2.66	2.71	2.76	V
				Falling interrupt voltage	2.60	2.65	2.70	V
	VLVDC3		LVIS1, LVIS0 = 0, 0	Rising release reset voltage	3.68	3.75	3.82	V
				Falling interrupt voltage	3.60	3.67	3.74	V
	VLVDD0	VPOC2,	VPOC1, VPOC0 = 0, 1, 1	, falling reset voltage	2.70	2.75	2.81	V
	VLVDD1		LVIS1, LVIS0 = 1, 0	Rising release reset voltage	2.86	2.92	2.97	V
				Falling interrupt voltage	2.80	2.86	2.91	V
	VLVDD2		LVIS1, LVIS0 = 0, 1	Rising release reset voltage	2.96	3.02	3.08	V
				Falling interrupt voltage	2.90	2.96	3.02	V
	VLVDD3		LVIS1, LVIS0 = 0, 0	Rising release reset voltage	3.98	4.06	4.14	V
				Falling interrupt voltage	3.90	3.98	4.06	V

2.6.5 Supply voltage rise time

(T_A = -40 to +85°C, Vss = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Power supply voltage rising slope	SVDD				54	V/ms

Caution Make sure to keep the internal reset state by the LVD circuit or an external reset until V_{DD} reaches the operating voltage range shown in 30.4 AC Characteristics.

Absolute Maximum Ratings (T_A = 25°C)

(3/3)

		-)			(••••)
Parameter	Symbols		Conditions	Ratings	Unit
Output current, high	Іон1	Per pin	P10 to P17, P30 to P32, P40 to P43, P50 to P54, P70 to P74, P120, P125 to P127, P130, P140 to P147	-40	mA
		Total of all pins –170 mA	P10 to P14, P40 to P43, P120, P130, P140 to P147	-70	mA
			P15 to P17, P30 to P32, P50 to P54, P70 to P74, P125 to P127	-100	mA
	Іон2	Per pin	P20, P21	-0.5	mA
		Total of all pins		-1	mA
Output current, low	lol1	Per pin	P10 to P17, P30 to P32, P40 to P43, P50 to P54, P60, P61, P70 to P74, P120, P125 to P127, P130, P140 to P147	40	mA
		Total of all pins 170 mA	P10 to P14, P40 to P43, P120, P130, P140 to P147	70	mA
			P15 to P17, P30 to P32, P50 to P54, P60, P61, P70 to P74, P125 to P127	100	mA
	IOL2	Per pin	P20, P21	1	mA
		Total of all pins		2	mA
Operating ambient	TA	In normal operation	on mode	-40 to +105	°C
temperature		In flash memory p	programming mode		
Storage temperature	Tstg			–65 to +150	°C

- Caution Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.
- **Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.



3.2 Oscillator Characteristics

3.2.1 X1, XT1 oscillator characteristics

$(T_A = -40 \text{ to } +105^{\circ}C, 2.4 \text{ V} \le EV_{DD} = V_{DD} \le 5.5 \text{ V}, \text{ Vss} = EV_{SS} = 0 \text{ V})$	
--	--

Parameter	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation	Ceramic resonator/	$2.7~V \leq V_{\text{DD}} \leq 5.5~V$	1.0		20.0	MHz
frequency (fx) ^{Note}	crystal resonator	$2.4~V \leq V_{\text{DD}} < 2.7~V$	1.0		16.0	MHz
XT1 clock oscillation frequency (fxT) ^{Note}	Crystal resonator		32	32.768	35	kHz

- **Note** Indicates only permissible oscillator frequency ranges. Refer to **3.4 AC Characteristics** for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.
- Caution Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

3.2.2 On-chip oscillator characteristics

$(T_A = -40 \text{ to } +105^{\circ}\text{C}, 2.4 \text{ V} \le \text{EV}_{\text{DD}} = \text{V}_{\text{DD}} \le 5.5 \text{ V}, \text{V}_{\text{SS}} = \text{EV}_{\text{SS}} = 0 \text{ V})$

Oscillators	Parameters	Conditions		MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency ^{Notes 1, 2}	fін			1		24	MHz
High-speed on-chip oscillator		–20 to +85°C	$2.4~V \leq V_{\text{DD}} \leq 5.5~V$	-1		+1	%
clock frequency accuracy		–40 to –20°C	$2.4~V \leq V_{\text{DD}} \leq 5.5~V$	-1.5		+1.5	%
		+85 to +105°C	$2.4~V \leq V_{\text{DD}} \leq 5.5~V$	-2.0		+2.0	%
Low-speed on-chip oscillator clock frequency	fı∟				15		kHz
Low-speed on-chip oscillator clock frequency accuracy				-15		+15	%

Notes 1. High-speed on-chip oscillator frequency is selected by bits 0 to 3 of option byte (000C2H) and bits 0 to 2 of HOCODIV register.

2. This indicates the oscillator characteristics only. Refer to 3.4 AC Characteristics for instruction execution time.



3.7.2 Internal voltage boosting method

(1) 1/3 bias method

(T_A = -40 to +105°C, 2.4 V \leq V_DD \leq 5.5 V, Vss = 0 V)

Parameter	Symbol	Cond	litions	MIN.	TYP.	MAX.	Unit
LCD output voltage variation range	VL1	C1 to C4 ^{Note 1}	VLCD = 04H	0.90	1.00	1.08	V
		= 0.47 <i>µ</i> F	VLCD = 05H	0.95	1.05	1.13	V
			VLCD = 06H	1.00	1.10	1.18	V
			VLCD = 07H	1.05	1.15	1.23	V
			VLCD = 08H	1.10	1.20	1.28	V
			VLCD = 09H	1.15	1.25	1.33	V
			VLCD = 0AH	1.20	1.30	1.38	V
			VLCD = 0BH	1.25	1.35	1.43	V
			VLCD = 0CH	1.30	1.40	1.48	V
			VLCD = 0DH	1.35	1.45	1.53	V
			VLCD = 0EH	1.40	1.50	1.58	V
			VLCD = 0FH	1.45	1.55	1.63	V
			VLCD = 10H	1.50	1.60	1.68	V
			VLCD = 11H	1.55	1.65	1.73	V
			VLCD = 12H	1.60	1.70	1.78	V
			VLCD = 13H	1.65	1.75	1.83	V
Doubler output voltage	VL2	C1 to C4 ^{Note 1} =	0.47 <i>μ</i> F	2 V∟1 –0.1	2 VL1	2 V _{L1}	V
Tripler output voltage	VL4	C1 to C4 ^{Note 1} = 0.47 μ F		3 V∟1 0.15	3 VL1	3 VL1	V
Reference voltage setup time Note 2	tvwait1			5			ms
		C1 to C4 ^{Note 1} =	0.47 <i>μ</i> F	500			ms

Notes 1. This is a capacitor that is connected between voltage pins used to drive the LCD.

C1: A capacitor connected between CAPH and CAPL

C2: A capacitor connected between $V_{\mbox{\tiny L1}}$ and GND

C3: A capacitor connected between $V_{\mbox{\tiny L2}}$ and GND

C4: A capacitor connected between $V_{{\mbox{\tiny L4}}}$ and GND

C1 = C2 = C3 = C4 = 0.47 μ F \pm 30%

2. This is the time required to wait from when the reference voltage is specified by using the VLCD register (or when the internal voltage boosting method is selected [by setting the MDSET1 and MDSET0 bits of the LCDM0 register to 01B] if the default value reference voltage is used) until voltage boosting starts (VLCON = 1).

3. This is the wait time from when voltage boosting is started (VLCON = 1) until display is enabled (LCDON = 1).

3.11 Timing Specifications for Switching Flash Memory Programming Modes (T_A = -40 to +105°C, 2.4 V \leq EV_{DD} = V_{DD} \leq 5.5 V, V_{SS} = EV_{SS} = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Time to complete the communication for the initial setting after the external reset is released	tsuinit	POR and LVD reset must be released before the external reset is released.			100	ms
Time to release the external reset after the TOOL0 pin is set to the low level	tsu	POR and LVD reset must be released before the external reset is released.	10			μs
Time to hold the TOOL0 pin at the low level after the external reset is released (excluding the processing time of the firmware to control the flash memory)	tнd	POR and LVD reset must be released before the external reset is released.	1			ms



- <1> The low level is input to the TOOL0 pin.
- <2> The external reset is released (POR and LVD reset must be released before the external reset is released.).
- <3> The TOOL0 pin is set to the high level.
- <4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.
- **Remark** tsuinit: Communication for the initial setting must be completed within 100 ms after the external reset is released during this period.
 - $t_{\text{su:}}$ Time to release the external reset after the TOOL0 pin is set to the low level
 - the: Time to hold the TOOL0 pin at the low level after the external reset is released (excluding the processing time of the firmware to control the flash memory)



4.5 64-pin Products

R5F10RLAAFA, R5F10RLCAFA R5F10RLAGFA, R5F10RLCGFA

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]	
P-LQFP64-12x12-0.65	PLQP0064JA-A	P64GK-65-UET-2	0.51	



Each lead centerline is located within 0.13 mm of its true position at maximum material condition.

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	Description			
Rev.	Date	Page	Summary	
2.00	2.00 Jan 10, 2014	35	Modification of table in 2.4 AC Characteristics	
		36	Addition of Minimum Instruction Execution Time during Main System Clock Operation	
		37	Modification of AC Timing Test Points and External System Clock Timing	
		39	Modification of AC Timing Test Points	
		39	Modification of description, notes 1 and 2 in (1) During communication at same potential (UART mode)	
		41, 42	Modification of description, remark 2 in (2) During communication at same potential (CSI mode)	
		42, 43	Modification of description in (3) During communication at same potential (CSI mode)	
		45	Modification of description, notes 1 and 3, and remark 3 in (4) Communication at different potential (1.8 V, 2.5 V, 3 V) (UART mode) (1/2)	
		46, 48	Modification of description, and remark 3 in (4) Communication at different potential (1.8 V, 2.5 V, 3 V) (UART mode) (2/2)	
		49, 50	Modification of table, and note 1, caution, and remark 3 in (5) Communication at different potential (2.5 V, 3 V) (CSI mode)	
		51	Modification of table and note in (6) Communication at different potential (1.8 V, 2.5 V, 3 V) (1/3)	
		52	Modification of table and notes 1 to 3 in (6) Communication at different potential (1.8 V, 2.5 V, 3 V) (2/3)	
		53, 54	Modification of table, note 3, and remark 3 in (6) Communication at different potential (1.8 V, 2.5 V, 3 V) (3/3)	
		56	Modification of table in (7) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (1/2)	
		57	Modification of table in (7) Communication at different potential (1.8 V, 2.5 V, 3 V) (CSI mode) (2/2)	
		59, 60	Addition of (1) I ² C standard mode	
		61	Addition of (2) I ² C fast mode	
		62	Addition of (3) I ² C fast mode plus	
		63	Addition of table in 2.6.1 A/D converter characteristics	
		63, 64	Modification of description and notes 3 to 5 in 2.6.1 (1)	
		65	Modification of description, notes 3 and 4 in 2.6.1 (2)	
		66	Modification of description, notes 3 and 4 in 2.6.1 (3)	
		67	Modification of description, notes 3 and 4 in 2.6.1 (4)	
		67	Modification of the table in 2.6.2 Temperature sensor/internal reference voltage characteristics	
		68	Modification of the table and note in 2.6.3 POR circuit characteristics	
		70	Modification of the table of LVD Detection Voltage of Interrupt & Reset Mode	
		70	Modification from VDD rise slope to Power supply voltage rising slope in 2.6.5 Supply voltage rise time	
		75	Modification of description in 2.10 Dedicated Flash Memory Programmer Communication (UART)	
		76	Modification of the figure in 2.11 Timing Specifications for Switching Flash Memory Programming Modes	
		77 to 126	Addition of products for industrial applications (G: T _A = -40 to +105°C)	
		127 to 133	Addition of product names for industrial applications (G: $T_A = -40$ to $+105^{\circ}C$)	
2.10	Sep 30, 2016	5	Modification of pin configuration in 1.3.1 32-pin products	
		6	Modification of pin configuration in 1.3.2 44-pin products	
		7	Modification of pin configuration in 1.3.3 48-pin products	
		8	Modification of pin configuration in 1.3.4 52-pin products	
		9, 10 17	Modification of pin configuration in 1.3.5 64-pin products	
		17 74	Modification of description of main system clock in 1.6 Outline of Functions	
		74	Modification of title of 2.8 RAM Data Retention Characteristics, Note, and figure Modification of table of 2.9 Flash Memory Programming Characteristics	
		123	Modification of title of 3.8 RAM Data Retention Characteristics, Note, and figure	
		123	Modification of table of 3.9 Flash Memory Programming Characteristics and addition of Note 4	
		131	Modification of 4.5 64-pin Products	
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NOTES FOR CMOS DEVICES

- (1) VOLTAGE APPLICATION WAVEFORM AT INPUT PIN: Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between VIL (MAX) and VIH (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between VIL (MAX) and VIH (MIN).
- (2) HANDLING OF UNUSED INPUT PINS: Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.
- (3) PRECAUTION AGAINST ESD: A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.
- (4) STATUS BEFORE INITIALIZATION: Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.
- (5) POWER ON/OFF SEQUENCE: In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current. The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.
- (6) INPUT OF SIGNAL DURING POWER OFF STATE : Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

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